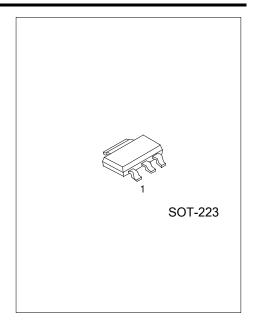
PZTA56 Advance

PNP SILICON TRANSISTOR

AMPLIFIER TRANSISTOR

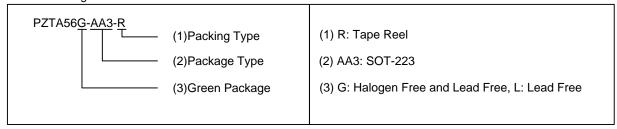
■ FEATURES

* Collector-Emitter Voltage: V_{CEO}= -80V

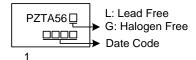


ORDERING INFORMATION

Γ	Ordering Number		Doolsone	Pin Assignment			Do akin n	
Γ	Lead Free	Halogen Free	Package	1	2	3	Packing	
Ī	PZTA56L-AA3-R	PZTA56G-AA3-R	SOT-223	В	С	Е	Tape Reel	



MARKING



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■ **ABSOLUTE MAXIMUM RATINGS** (T_A=25°C, unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT
Collector-Base Voltage	V_{CBO}	-80	V
Collector-Emitter Voltage	V _{CEO}	-80	V
Emitter-Base Voltage	V _{EBO}	-4	V
Collector Current - Continuous	Ic	-500	mA
Total Device Dissipation (Note 2)	Ъ	1000	mW
Derate Above 25°C	P _D	8	mW/°C
Junction Temperature	TJ	+150	°C
Storage Temperature	T _{STG}	-55 ~ + 150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ_{JA}	125	°C/W	

■ **ELECTRICAL CHARACTERISTICS** (T_A=25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
OFF CHARACTERISTICS							
Collector-Emitter Breakdown Voltage (Note 1)	BV _{CEO}	I _C =-1mA, I _B =0	-80			V	
Collector-Base Breakdown Voltage	BV _{CBO}	$I_{C}=100\mu A, I_{E}=0$	-60			V	
Emitter-Base Breakdown Voltage	BV _{EBO}	I _E =-100μA, I _C =0	-4			V	
Collector Cutoff Current	I _{CES}	V_{CE} =-60V, I_{B} =0			-0.1	μΑ	
Collector Cutoff Current	I _{CBO}	V_{CB} =-80V, I_{E} =0			-0.1	μΑ	
ON CHARACTERISTICS							
DC Current Gain	n	I _C =-10mA, V _{CE} =-1V	100				
DC Current Gain		I _C =-100mA, V _{CE} =-1V	100				
Collector-Emitter Saturation Voltage	V _{CE(SAT)}	I _C =-100mA, I _B =-10mA			-0.25	V	
Base-Emitter on Voltage	V _{BE(ON)}	I _C =-100mA, V _{CE} =-1V			-1.2	V	
SMALL-SIGNAL CHARACTERISTICS							
Current Gain Bandwidth Product (Note2)	f⊤	I _C =-100mA, V _{CE} =-1V, f=100MHz	50			MHz	

Notes: 1: Pulse test: $P_W \le 300 \mu s$, Duty Cycle $\le 2\%$.

^{2.} Device mounted on FR-4=1.6x1.6x0.06 in.

^{2:} f_T is defined as the frequency at which Ihfel extrapolates to unity.

■ SWITCHING TIME TEST CIRCUITS

UTC assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all UTC products described or contained herein. UTC products are not designed for use in life support appliances, devices or systems where malfunction of these products can be reasonably expected to result in personal injury. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner. UTC reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.